		Me
	Application No.	Applicant(s)
Notice of Allowability	09/667,966 Examiner	CHEN, ZEWU Art Unit
	Therese Barber	2882
The MAILING DATE of this communication All claims being allowable, PROSECUTION ON THE MERIT herewith (or previously mailed), a Notice of Allowance (PTOL NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATEN of the Office or upon petition by the applicant. See 37 CFR 1. This communication is responsive to 11 September 2 2. The allowed claim(s) is/are 1,3-6,8-18,21,22,24 and 4 3. The drawings filed on 22 September 2002 and 06 Fet 1 4. Acknowledgment is made of a claim for foreign priority a) All b) Some* c) None of the: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the priority International Bureau (PCT Rule 17.2(a * Certified copies not received: 5. Acknowledgment is made of a claim for domestic priority.	S IS (OR REMAINS) CLOSED in 2-85) or other appropriate community RIGHTS. This application is a 1.313 and MPEP 1308. 1.313 and MPEP 1308. 1.314-64. 1.315 are accepted by the y under 35 U.S.C. § 119(a)-(d) or have been received. 1.316 have been received in Application	n this application. If not included unication will be mailed in due course. THIS subject to withdrawal from issue at the initiative Examiner. on No d in this national stage application from the
 (a) ☐ The translation of the foreign language provisio 6. ☐ Acknowledgment is made of a claim for domestic prior Applicant has THREE MONTHS FROM THE "MAILING DAT below. Failure to timely comply will result in ABANDONMEN 	rity under 35 U.S.C. §§ 120 and/o	or 121. a reply complying with the requirements noted
7. A SUBSTITUTE OATH OR DECLARATION must be INFORMAL PATENT APPLICATION (PTO-152) which gives		
 CORRECTED DRAWINGS must be submitted. (a) including changes required by the Notice of Draft 1) hereto or 2) to Paper No. (b) including changes required by the proposed draw (c) including changes required by the attached Exan Identifying indicia such as the application number (see 37 C each sheet. 	ving correction filed, which	ch has been approved by the Examiner. or in the Office action of Paper No
9. DEPOSIT OF and/or INFORMATION about the cattached Examiner's comment regarding REQUIREMENT FOR		
Attachm nt(s)		
1⊠ Notice of References Cited (PTO-892) 3□ Notice of Draftperson's Patent Drawing Review (PTO-94 5□ Information Disclosure Statements (PTO-1449), Paper N 7□ Examiner's Comment Regarding Requirement for Depos of Biological Material	8) 4☐ Interview No 6☐ Examine	of Informal Patent Application (PTO-152) ov Summary (PTO-413), Paper No er's Amendment/Comment er's Statement of Reasons for Allowance

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DETAILED ACTION

Response to Arguments

1. Applicant's remarks filed on 11 September 2003 regarding the objections to figures 8-10 has been overcome by the amendment to the specification.

Allowable Subject Matter

- 2. Claims 1, 3-6, 8-18, 21,22, 24, 41-64 are allowed.
- 3. Regarding claims 1, 3-6, 8-13, and 49, the examiner agrees with the applicant's arguments on pages 11-16, dated 11 September 2003, regarding the 103 rejections based on the combination of the Wittry and Ohsugi patents. Claims 1, 3-6, 8-13, and 49 are allowable because the prior art of record fails to teach or to reasonably suggest a total reflection x-ray fluorescence apparatus having a doubly curved x-ray optic for diffracting and focusing x-rays, in order to detect x-ray fluorescence that is emitted by foreign matter that is present on a surface, as set forth in the claimed combination.
- 4. Regarding claims 14-17 and 57, the claims are allowable because the prior art fails to teach or to reasonably suggest a total reflection x-ray fluorescence apparatus having a doubly-curved x-ray optic for diffracting and focusing x-rays wherein the locations of the doubly-curved x-ray optic, x-ray source, and point of impingement define an optical circle of radius R, wherein the doubly-curved x-ray optic has an optical surface of radius 2R and one or more atomic planes

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are essentially parallel with the optic surface, in order to detect x-ray fluorescence that is emitted by foreign matter that is present on a surface, as set forth in the claimed combination.

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- 5. Regarding claims 18, 21, 22, 24, and 50, the examiner agrees with the applicant's arguments on pages 11-16, dated 11 September 2003, regarding the 103 rejections based on the combination of the Wittry and Ohsugi patents. Claims 18, 21, 22, 24, and 50 are allowable because the prior art of record fails to teach or to reasonably suggest the combination of steps of detecting foreign matter on a surface by utilizing a total reflection x-ray fluorescence apparatus that has a doubly curved x-ray optic for diffracting and focusing x-rays, as set forth in the claimed combination.
- 6. Regarding claims 41-48 and 64, the claims are allowable because the prior art fails to teach or to reasonably suggest a total reflection x-ray fluorescence apparatus having a doublycurved x-ray optic for diffracting and focusing x-rays, wherein the x-ray source and the point of impingement upon the surface define an optic circle of radius R, and wherein the doubly-curved x-ray optic comprises a surface and a plurality of atomic plane of radius R_p, which intersect the surface at an angle α ; and wherein the radius of the atomic planes R_p of the doubly-curved optic is defined by the equation $R_p = 2R \cos \alpha$, in order to detect x-ray fluorescence that is emitted by foreign matter that is present on a surface, as set forth in the claimed combination.
- 7. Regarding claim 51-56 and 58-63, the claims are allowable because the prior art fails to teach or to reasonably suggest a total reflection fluorescence apparatus and the steps of utilizing

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the total reflection fluorescence apparatus to detect foreign matter utilizing a doubly curved x-ray optic for diffracting and focusing x-rays, wherein the doubly curved x-ray optic has a backing plate, an adhesive layer, and an optical layer having a desired curvature and thickness, as set forth in the claimed combination.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

- 8. The applicants have canceled claims 2,7, 19, 20, 23, and 25-40.
- 9. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Wittry (USPN 6,498,830 B2) discloses a method and apparatus for fabricating a doubly curved crystal for the diffraction of x-rays in spectrometer, monochromators, or point-focusing instrument.

Chen (USPN 6,317,483 B2) discloses a doubly curved optical device having multiple reflection planes separated by a spacing (d), which varies in at least one direction.

Chen (USPN 6,285,506 B1) discloses a method for fabricating an optically curved element and an optically curved element wherein the optically curved element includes a backing plate, an adhesive layer, and a flexible layer having a desired curvature and thickness.

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Wittry (USPN 6,236,710 B1) discloses a curved crystal optical device for the diffraction of x-rays in spectrometers or instruments for microanalysis and the method of fabricating the curved crystal.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Therese Barber whose telephone number is (703) 306-0205. The examiner can normally be reached on Monday to Friday from 8:30 a.m. to 6:00 p.m..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Edward Glick can be reached on (703) 308-4858. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 305-4900.

30 November 2003

PAVID V. RRUCE PRIMARY ExamiNER